Notice of References Cited Application/Control No. 10/574,689 Applicant(s)/Patent Under Reexamination SHIMADA ET AL. Examiner REBECCA LEE 1793 Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
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	Ι	US-			
	-	US-			
	7	US-			
	K	US-			
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	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	JP 02234349 A	09-1990	Japan	TANIGUCHI et al.	H01M 04/02
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NON-PATENT DOCUMENTS

	NON-FATENT DOCUMENTS							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U	machine translation of JP 10041062						
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